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Application Number	10/077.922		
Filing Date	02/19/2002		
First Named Inventor	Jeffrey L. Helfer		
Art Unit	2872		
Examiner Name			
Attorney Docket Number	BTI-18		

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First Named Inventor	Jeffrey L. Helfer		
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Attorney Docket Number	DTI 40		

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Application Number	10/077.922		
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First Named Inventor	Jeffrev L. Helfer		
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Attorney Docket Number	BTI-18		

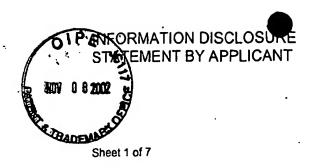
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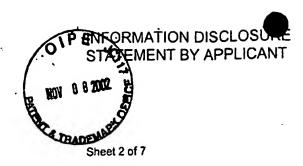
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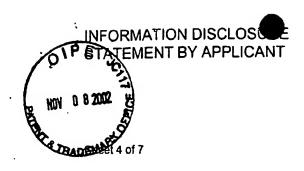
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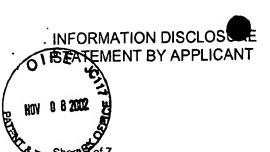
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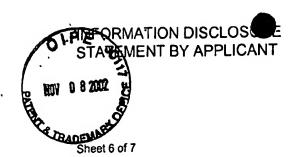


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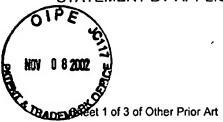
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INFORMATION DISCLOSURE STATEMENT BY APPLICANT



Application Number 10/077,922
Filing Date February 19, 2002
First Named Inventor Stuart G. MacDonald
Group Art Unit 2872
Examiner Name
Docket BTI-18

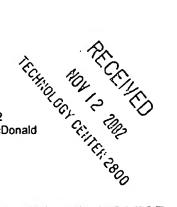


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